


Sheet <u>1</u> of <u>1</u> FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) <i>(Use several sheets if necessary)</i>		ATTY DOCKET NO. WATK:204		SERIAL NO. 09/701,430					
		APPLICANT Toshio YAMADA et al.		FILING DATE November 29, 2000				GROUP 1764	
U.S. PATENT DOCUMENTS									
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE			
FOREIGN PATENT DOCUMENTS									
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION NO YES			
mr	WO 98/35144	8/13/98	PCT	_____	_____				
m	0 643 204 A2	3/15/95	Europe	_____	_____				
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)									
EXAMINER	Hien Tran			DATE CONSIDERED		4/22/04			

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FORM PTO 1449 (modified)

ATTY DOCKET NO.  
WATK:204SERIAL NO.  
09/701,430U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICEAPPLICANT  
Toshio YAMADA et al.

OCT 21 2002

LIST OF REFERENCES CITED BY APPLICANT(S)  
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## U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
my						

## FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION NO YES	
my	9-228829	9/2/97	Japan (w/English Abstract)			X	
	6-254409	9/13/94	Japan (w/English Abstract)			X	
	8-89815	4/9/96	Japan (w/English Abstract)			X	
my	10-29077	2/3/98	Japan (w/English Abstract)			X	

## OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)


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		APPLICANT Toshio YAMADA et al.				
		FILING DATE November 29, 2000		GROUP 1764		
U.S. PATENT DOCUMENTS						
*EXAMINER INITIAL <i>my</i> DEC 07 2001 PATENT & TRADEMARK OFFICE	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	4,093,423	06/06/1978	Neumann	<del>25</del> 422	<del>288</del> 180	10/03/1973
FOREIGN PATENT DOCUMENTS						
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION NO YES
<i>my</i>	EP 1 020 621 A2	07/19/2000	Europe			Yes
	EP 0 947 673 A2	10/06/1999	Europe			Yes
	EP 0 859 133 A1	08/19/1998	Europe			Yes
	09-317455	12/09/1997	Japan			Abstract
	EP 0 807 466 A2	11/19/1997	Europe			Yes
<i>my</i>	EP 0 807 466 A3	11/19/1997	Europe			Yes
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)						
EXAMINER			DATE CONSIDERED			

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Sheet 1 of 1

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U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY APPLICANT(S)  
(Use several sheets if necessary)ATTY DOCKET NO.  
NGK INSULATORS, LTD.SERIAL NO. 09/701430  
PCT/JP00/03420APPLICANT  
Toshio YAMADA et al.FILING DATE  
November 29, 2000

GROUP 1764

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

## FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION NO YES	
H5	2788871	3/20/95	Japan (w/English abstract)			X	

## OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)


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